



# N-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
8	0.054 at V <sub>GS</sub> = 4.5 V	3.5					
	0.060 at V <sub>GS</sub> = 2.5 V	3.3					
	0.068 at V <sub>GS</sub> = 1.8 V	3.1	4.3 nC				
	0.086 at V <sub>GS</sub> = 1.5 V	2.3					
	0.135 at V <sub>GS</sub> = 1.2 V	1					

### MICRO FOOT







Backside View

Device Marking: xxx = Date/Lot Traceability Code

### Ordering Information:

Si8802DB-T2-E1 (Lead (Pb)-free and Halogen-free)

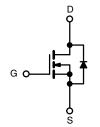
### **FEATURES**

- TrenchFET® Power MOSFET
- Small 0.8 mm x 0.8 mm Outline Area
- Low 0.4 mm max. profile
- Low On-Resistance
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

HALOGEN FREE

### **APPLICATIONS**

- · Load Switch with Low Voltage Drop
- Load Switch for 1.2 V, 1.5 V, 1.8 V **Power Lines**
- Smart Phones, Tablet PCs, Portable Media Players



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	$IGS T_A = 25 °C,$	unless otherv	vise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	8	V	
Gate-Source Voltage		V <sub>GS</sub>	± 5		
	T <sub>A</sub> = 25 °C		3.5 <sup>a</sup>		
Continuous Prain Current (T = 150 °C)	T <sub>A</sub> = 70 °C	1 , [	2.8 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub> –	3 <sup>b</sup>		
	T <sub>A</sub> = 70 °C	1	2.4 <sup>b</sup>	A	
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	15		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		0.7 <sup>a</sup>		
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.4 <sup>b</sup>		
	T <sub>A</sub> = 25 °C		0.9 <sup>a</sup>		
Maximum Power Dissipation	T <sub>A</sub> = 70 °C	1 , [	0.6 <sup>a</sup>	w	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.5 <sup>b</sup>	vv	
	T <sub>A</sub> = 70 °C	1	0.3 <sup>b</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>c</sup>			260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>a, d</sup>	t ≤ 5 s	D	105	135	°C/W		
Maximum Junction-to-Ambient <sup>b, e</sup>	1 1238	R <sub>thJA</sub>	200	260			

- a. Surface mounted on 1" x 1" FR4 board with full copper, t=5 s. b. Surface mounted on 1" x 1" FR4 board with minimum copper, t=5 s.
- c. Refer to IPC/JEDEC (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C/W.
- e. Maximum under steady state conditions is 330 °C/W.

## **Si8802DB**

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Parameter	Symbol Test Conditions			Тур.	Max.	Unit	
Static	-			, ,,		l	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	8			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 0504		7		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 2.1			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.35		0.7	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	nA	
Zana Oata Valla va Busin Oamani		V <sub>DS</sub> = 8 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 8 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$		0.044	0.054	Ω	
		$V_{GS} = 2.5 \text{ V}, I_D = 1 \text{ A}$		0.049	0.060		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.5 A		0.055	0.068		
	==(***)	$V_{GS} = 1.5 \text{ V}, I_D = 0.2 \text{ A}$		0.060	0.086		
		V <sub>GS</sub> = 1.2 V, I <sub>D</sub> = 0.1 A		0.080	0.135		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 4 V, I <sub>D</sub> = 1 A		13		S	
Dynamic <sup>b</sup>				l		·	
Total Gate Charge	$Q_{g}$			4.3	6.5		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$		0.44		nC	
Gate-Drain Charge	Q <sub>gd</sub>			0.72			
Gate Resistance	$R_{g}$	f = 1 MHz	MHz			Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			5	10		
Rise Time	t <sub>r</sub>	$V_{DD} = 4 \text{ V}, R_L = 4 \Omega$		15	30	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 1 A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		22	40	ns	
Fall Time	t <sub>f</sub>			7	15		
Drain-Source Body Diode Characteristic	s			l		·	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>A</sub> = 25 °C			0.7	Α	
Pulse Diode Forward Current	I <sub>SM</sub>				15		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V		0.7	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			20	40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 1 A, dI/dt = 100 A/μs, T <sub>.I</sub> = 25 °C		5	10	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F - I_A$ , $uI/uI = 100 A/\mu s$ , $I_J = 25 ^{\circ} C$		14			
Reverse Recovery Rise Time	t <sub>b</sub>			60		ns	

### Notes:

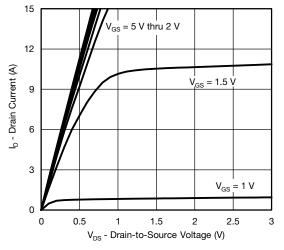
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %

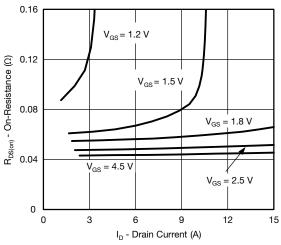
b. Guaranteed by design, not subject to production testing.



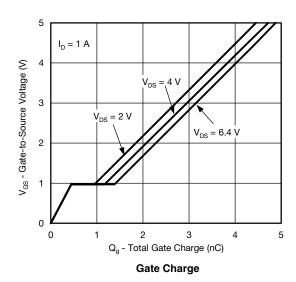
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

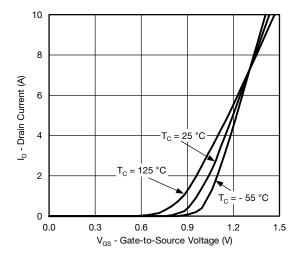


### **Output Characteristics**

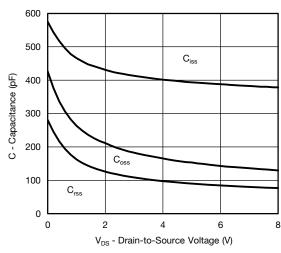


On-Resistance vs. Drain Current

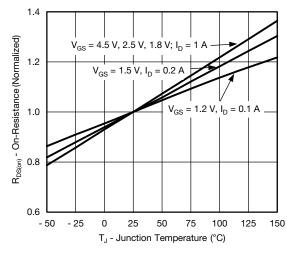




**Transfer Characteristics** 



Capacitance



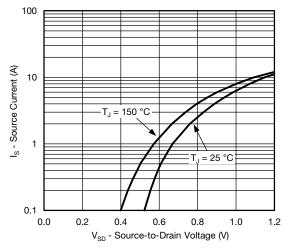
On-Resistance vs. Junction Temperature

0.15

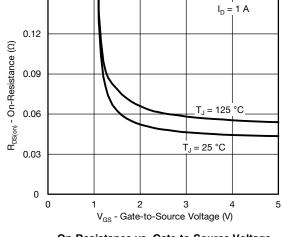
# **Si8802DB**

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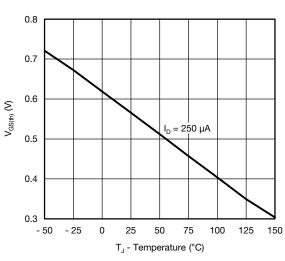
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



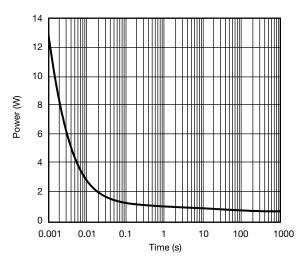




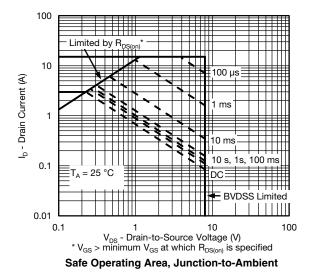
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

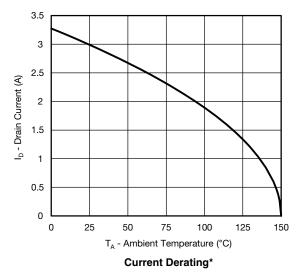


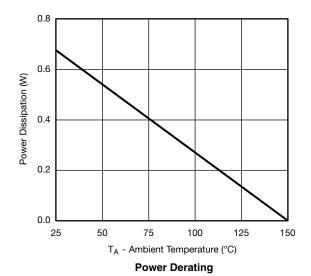
Single Pulse Power (Junction-to-Ambient)





## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Note:

When mounted on 1" x 1" FR4 with full copper.

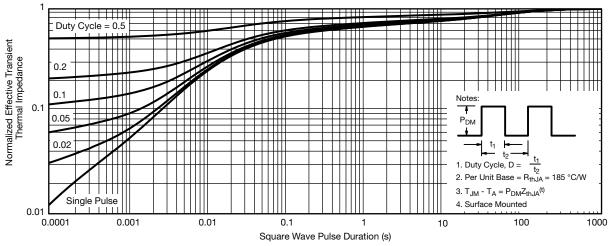
 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150  $^{\circ}$ C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

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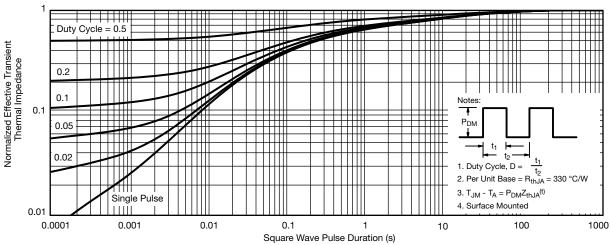
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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 board with maximum copper)

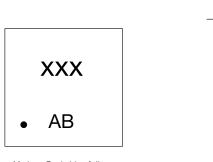


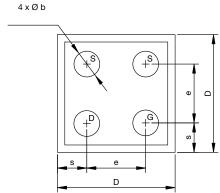
Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 board with minimum copper)



### **PACKAGE OUTLINE**

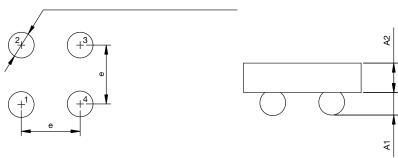
## MICRO FOOT 0.8 mm x 0.8 mm: 4-BUMP (2 x 2, 0.4 mm PITCH)





Mark on Backside of die

4 x Ø 0.205 to 0.225 Note 4 Solder Mask ~ Ø 0.215



Recommended Land

Notes (Unless otherwise specified):

- 1. All dimensions are in millimeters.
- 2. Four (4) solder bumps are lead (Pb)-free 95.5Sn/3.5Ag/0.7Cu with diameter Ø 0.165 mm to Ø 0.185 mm.
- 3. Backside surface is coated with a Ti/Ni/Ag layer.
- 4. Non-solder mask defined copper landing pad.
- 5. is location of pin 1.

Dim.	Millimeters <sup>a</sup>			Inches			
	Min.	Nom.	Max.	Min.	Nom.	Max.	
Α	0.314	0.357	0.400	0.0124	0.0141	0.0157	
A <sub>1</sub>	0.127	0.157	0.187	0.0050	0.0062	0.0074	
A <sub>2</sub>	0.187	0.200	0.213	0.0074	0.0079	0.0084	
b	0.165	0.175	0.185	0.0064	0.0068	0.0072	
е	0.400			0.0157			
s	0.180	0.200	0.220	0.0070	0.0078	0.0086	
D	0.760	0.800	0.840	0.0299	0.0314	0.0330	

a. Use millimeters as the primary measurement.

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